Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,668	HOEK, AREND	
Examiner	Art Unit	
Tam M. Nguyen	1764	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH N (INCLUDING SEARC)
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east	2/19/2007	TN
inventors searched in eDan	2/19/2007	tn
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